

Maximum Ratings

Symbol	Conditions	Values	Units
V_{CEVsus}	$I_C = 1 A, V_{BE} = -2 V$	1000	V
V_{CEV}	$V_{BE} = -2 V$	1000	V
V_{CBO}	$I_E = 0$	1000	V
V_{EBO}	$I_C = 0$	7	V
I_C	D. C.	200	A
$I_F = -I_C$	D. C.	200	A
I_B		10	A
P_{tot}	$T_{case} = 25 ^\circ C$	1560	W
T_{vj}		-40 ... +150	$^\circ C$
T_{stg}		-40 ... +125	$^\circ C$
V_{isol}	a. c. 50 Hz, r.m.s.	2500~	V

Thermal Characteristics

R_{thjc}	darlington	0,08	$^\circ C/W$
R_{thjc}	diode	0,35	$^\circ C/W$
R_{thch}	module	0,04	$^\circ C/W$

Electrical Characteristics¹⁾

		min.	typ.	max.	
I_{CEV}	$V_{CE} = V_{CEV}, V_{BE} = -2 V$			4	mA
I_{EBO}	$I_C = 0, V_{BE} = -7 V$			800	mA
$V_{CEsat}^{2)}$	$I_C = 200 A, I_B = 4 A$			2,5	V
$V_{BEsat}^{2)}$	$I_C = 200 A, I_B = 4 A$			3,5	V
$h_{21E}^{2)}$	$I_C = 200 A$	$V_{CE} = 2,8 V$	75		
		$V_{CE} = 5 V$	100		

Switching Characteristics for Resistive Load¹⁾

t_{on}	} $I_C = 200 A$ $I_{B1} = -I_{B2} = 4 A$ $V_{CC} = 600 V$		3	μs
t_s			15	μs
t_f			3	μs

Inverse Diode Characteristics¹⁾

$V_F = -V_{CE}$	$I_F = -I_C = 200 A$			1,8	V
$I_{FSM} = -I_{cp}$	$\sin 180^\circ, 10 ms$	2000			A
I_{RM}	} $I_F = -I_C = 200 A, -di_F/dt = 100 A/\mu s$ $V_{BE} = -3 V, V_R = V_{CE} = 400 V,$ $T_{vj} = 125 ^\circ C$		40		A
Q_{rr}			20		μC

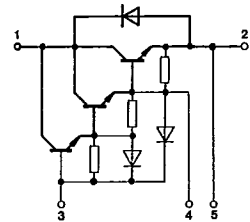
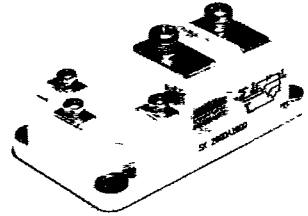
Mechanical Data

M_1	Case to heatsink	SI units	3	6	Nm
		US units	27	53	lb. in.
M_2	Busbars to	terminals 1, 2	SI units	2,5	5 Nm
			US units	22	44 lb. in.
		terminals 3 ... 5	SI units	1,1	2 Nm
			US units	10	18 lb. in.
w			475	g	
Case			D 18		

SEMITRANS® 4 NPN
Power Darlington Modules
200 A, 1000 V

SK 200 DA 100 D

T-33-35



Features

- Isolated baseplate (ease of mounting of one or several modules on one heatsink)
- All electrical connections on top (ease of interconnecting of modules with busbars)
- Large clearances and creepage distances
- Parallel connected fast recovery inverse diode
- UL recognized, file no. E 63 532

Typical Applications

- Uninterruptible power supplies (UPS)
- DC drives
- AC motor controls

¹⁾ $T_{case} = 25 ^\circ C$ unless otherwise stated

²⁾ $t_p \leq 300 \mu s, D \leq 1,5 \%$

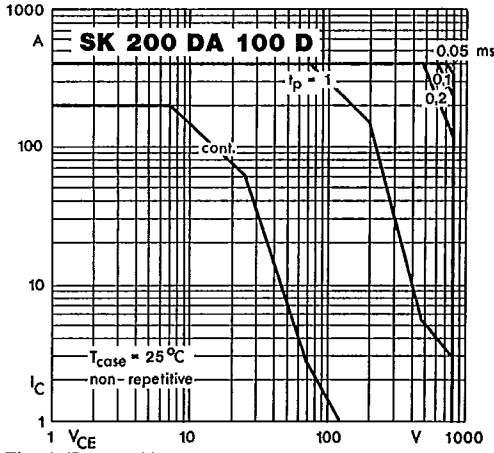


Fig. 1 Forward biased safe operating area (FBSOA)

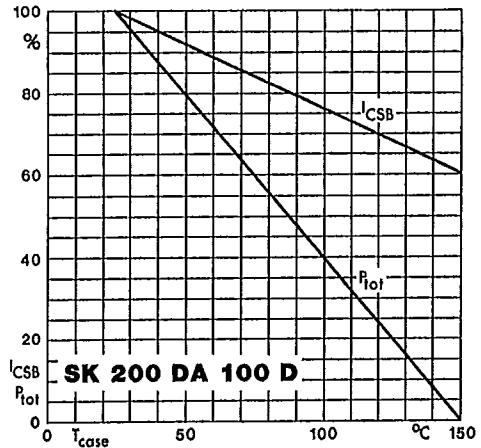


Fig. 2 Shifting the limits of the FBSOA with temperature

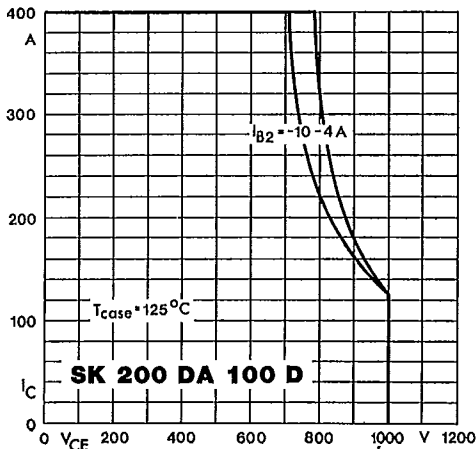


Fig. 3 Reverse biased safe operating area (RBSOA)

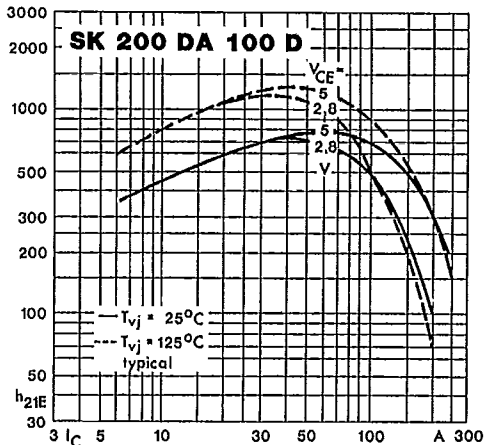


Fig. 4 Forward current transfer ratio vs. coll. current

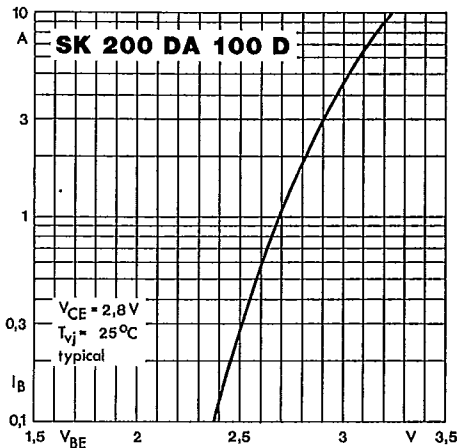


Fig. 5 Base current/voltage characteristic

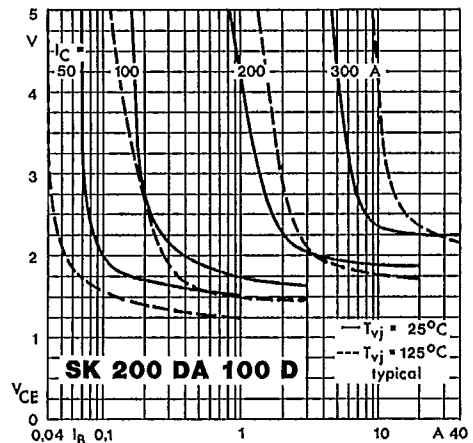


Fig. 6 Collector-emitter voltage vs. base current

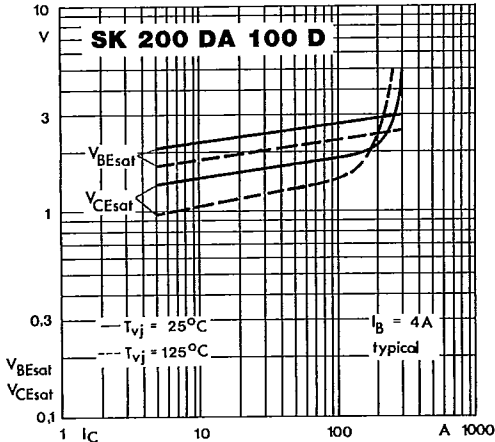


Fig. 7 Saturation voltages vs. collector current

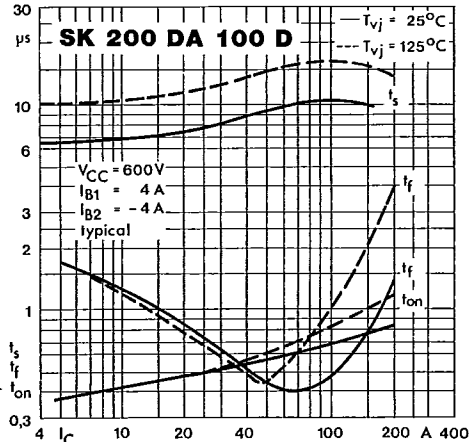


Fig. 8 Switching times vs. collector current

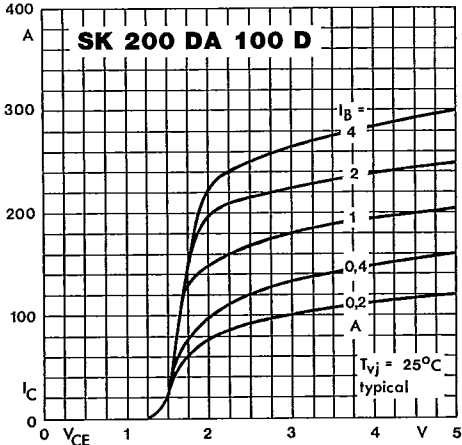


Fig. 9 Collector current/voltage characteristics

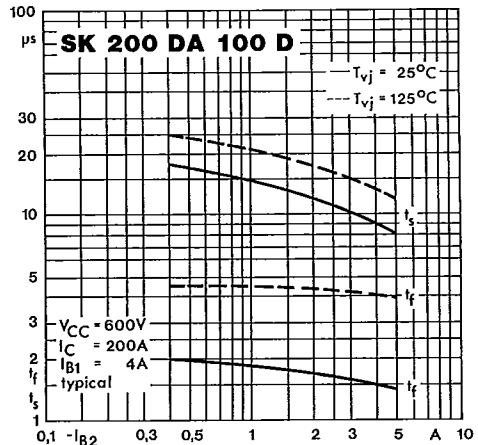


Fig. 10 Turn-off times vs. negative base current

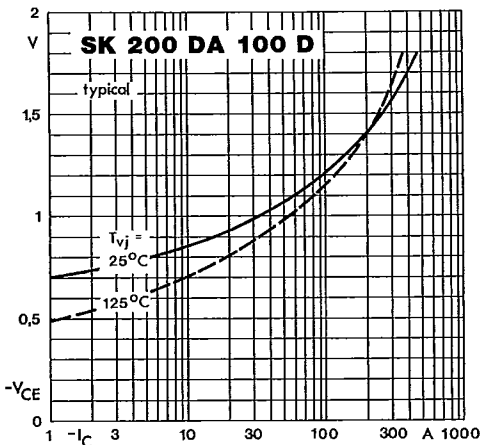


Fig. 11 Inverse diode forward characteristics

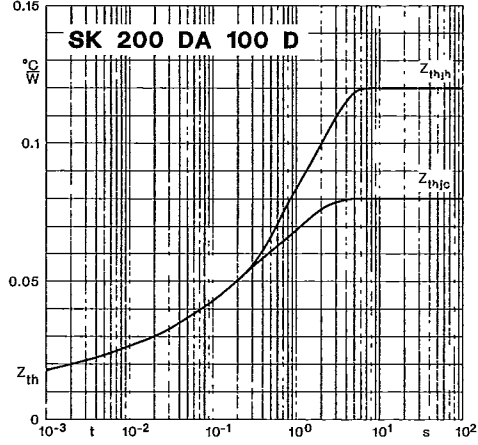


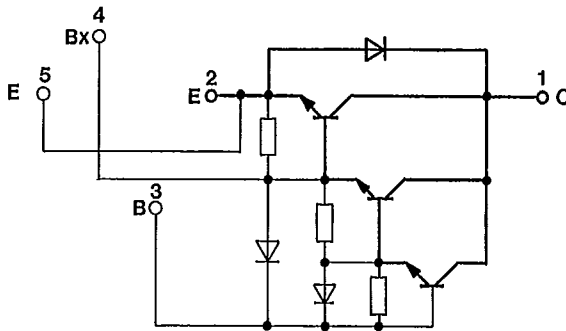
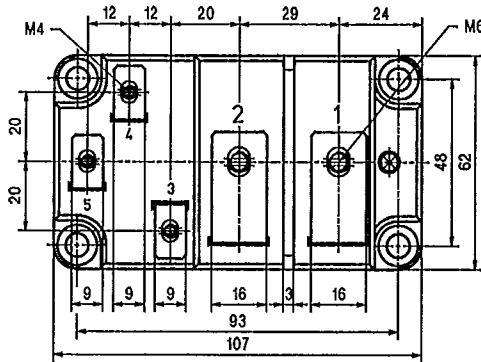
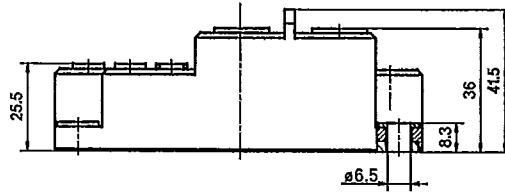
Fig. 12 Transient thermal impedance vs. time

SK 200 DA 100 D

Case D 18

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UL recognized,
file no. E 63 532



Dimensions in mm